

# N-Channel 40 V (D-S) MOSFET

PRODUCT SUMMARY					
V <sub>DS</sub> (V)	$R_{DS(on)}(\Omega)$	I <sub>D</sub> (A) <sup>a, e</sup>	Q <sub>g</sub> (Typ.)		
40	0.0009 at V <sub>GS</sub> = 10 V	200	138 nC		
40	$0.0013$ at $V_{GS} = 4.5 \text{ V}$	170	130 110		

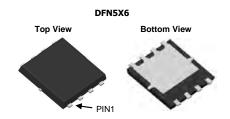
### **FEATURES**

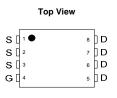
- DT-Trench Power MOSFET
- 100 %  $R_g$  and UIS Tested

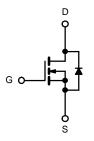


### **APPLICATIONS**

- · Notebook PC Core
- VRM/POL







N-Channel MOSFET

Parameter	Symbol	Limit	Unit		
Drain-Source Voltage		V <sub>DS</sub>	40	V	
Gate-Source Voltage		V <sub>GS</sub>	± 20	v	
	T <sub>C</sub> = 25 °C		200 <sup>a, e</sup>		
Continuous Drain Current (T <sub>J</sub> = 175 °C)	T <sub>C</sub> = 70 °C	I <sub>D</sub>	178 <sup>e</sup>		
Continuous Diain Curient (1) = 175 C)	T <sub>A</sub> = 25 °C	טי	60 <sup>b, c</sup>	A	
	T <sub>A</sub> = 70 °C		35.9 <sup>b, c</sup>		
Pulsed Drain Current		I <sub>DM</sub>	560		
Avalanche Current Pulse	L = 0.1 mH	I <sub>AS</sub>	58		
Single Pulse Avalanche Energy		E <sub>AS</sub>	670	mJ	
Continuous Source-Drain Diode Current	T <sub>C</sub> = 25 °C	I <sub>S</sub>	200 <sup>a, e</sup>	А	
Continuous Gource-Drain Diode Current	T <sub>A</sub> = 25 °C	'5	6.25 <sup>b, c</sup>		
	T <sub>C</sub> = 25 °C		150 <sup>a</sup>	W	
Maximum Power Dissipation	T <sub>C</sub> = 70 °C	P <sub>D</sub>	105		
Maximum Power Dissipation	T <sub>A</sub> = 25 °C	' D	5.25 <sup>b, c</sup>		
	T <sub>A</sub> = 70 °C		3.68 <sup>b, c</sup>		
Operating Junction and Storage Temperature Range		T <sub>J</sub> , T <sub>stg</sub>	- 55 to 175	°C	

THERMAL RESISTANCE RATINGS						
Parameter		Symbol	Typical	Maximum	Unit	
Maximum Junction-to-Ambient <sup>b, d</sup>	t ≤ 10 s	R <sub>thJA</sub>	13	18	°C/W	
Maximum Junction-to-Case	Steady State	R <sub>thJC</sub>	0.4	0.65	-C/VV	

### Notes:

- a. Based on T<sub>C</sub> = 25 °C. b. Surface mounted on 1" x 1" FR4 board.
- d. Maximum under steady state conditions is 90 °C/W.
- e. Calculated based on maximum junction temperature. Package limitation current is 180 A.



# DTQ6410 www.din-tek.jp

Parameter	Symbol	Test Conditions	Min .	Тур.	Max.	Unit
Static						
Drain-Source Breakdown Voltage	$V_{DS}$	$V_{GS} = 0 \text{ V}, I_D = 250 \mu\text{A}$		40		V
V <sub>DS</sub> Temperature Coefficient	$\Delta V_{DS}/T_{J}$	I <sub>D</sub> = 250 μA		35		mV/°C
V <sub>GS(th)</sub> Temperature Coefficient	$\Delta V_{GS(th)}/T_{J}$	1Β = 200 μΛ		- 5.5		
Gate-Source Threshold Voltage	V <sub>GS(th)</sub>	$V_{DS} = V_{GS}, I_{D} = 250 \mu A$	1		3	V
Gate-Source Leakage	I <sub>GSS</sub>	$V_{DS} = 0 \text{ V}, V_{GS} = \pm 20 \text{ V}$			± 100	nA
Zoro Coto Voltago Proin Current	I <sub>DSS</sub>	$V_{DS} = 32 \text{ V}, V_{GS} = 0 \text{ V}$			1	μ.Λ
Zero Gate Voltage Drain Current		V <sub>DS</sub> = 32 V, V <sub>GS</sub> = 0 V, T <sub>J</sub> = 55 °C			10	μA
On-State Drain Current <sup>a</sup>	I <sub>D(on)</sub>	$V_{DS} \ge 5 \text{ V}, V_{GS} = 10 \text{ V}$	200			Α
D : 0	D	V <sub>GS</sub> = 10 V, I <sub>D</sub> = 30 A		0.0009	0.0012	Ω
Drain-Source On-State Resistance <sup>a</sup>	R <sub>DS(on)</sub>	$V_{GS} = 4.5 \text{ V}, I_D = 20 \text{ A}$		0.0013	0.0017	
Forward Transconductance <sup>a</sup>	9 <sub>fs</sub>	V <sub>DS</sub> = 15 V, I <sub>D</sub> = 15 A		80		S
Dynamic <sup>b</sup>						
Input Capacitance	C <sub>iss</sub>			6385		pF
Output Capacitance	C <sub>oss</sub>	$V_{DS} = 15 \text{ V}, V_{GS} = 0 \text{ V}, f = 1 \text{ MHz}$		4717		
Reverse Transfer Capacitance	C <sub>rss</sub>			223		
Total Gate Charge	Qg	V <sub>DS</sub> = 15 V, V <sub>GS</sub> = 10 V, I <sub>D</sub> = 20 A		138		nC
				61.3		
Gate-Source Charge	$Q_{gs}$	$V_{DS} = 15 \text{ V}, V_{GS} = 4.5 \text{ V}, I_{D} = 20 \text{ A}$		19		
Gate-Drain Charge	$Q_{gd}$			13		
Gate Resistance	$R_g$	f = 1 MHz		1.5	2.2	Ω
Turn-On Delay Time	t <sub>d(on)</sub>			15	22	
Rise Time	t <sub>r</sub>	$V_{DD}$ = 15 V, $R_L$ = 0.555 $\Omega$		11	16	ns
Turn-Off Delay Time	t <sub>d(off)</sub>	$I_D \cong 30A$ , $V_{GEN} = 10 \text{ V}$ , $R_g = 1 \Omega$		57	88	
Fall Time	t <sub>f</sub>			12	17	
Turn-On Delay Time	t <sub>d(on)</sub>			12	20	
Rise Time	t <sub>r</sub>	$V_{DD}$ = 15 V, $R_L$ = 0.625 $\Omega$		160	225	
Turn-Off Delay Time	t <sub>d(off)</sub>	$I_D\cong 20$ A, $V_{GEN}=4.5$ V, $R_g=1$ $\Omega$		55	83	
Fall Time	t <sub>f</sub>			13	18	
<b>Drain-Source Body Diode Characteristics</b>	3					
Continuous Source-Drain Diode Current	I <sub>S</sub>	$T_C = 25  ^{\circ}C$			200	Α
Pulse Diode Forward Current <sup>a</sup>	I <sub>SM</sub>				560	
Body Diode Voltage	$V_{SD}$	I <sub>S</sub> = 22 A		0.8	1.2	V
Body Diode Reverse Recovery Time	t <sub>rr</sub>			35	58	ns
Body Diode Reverse Recovery Charge	Q <sub>rr</sub>	I <sub>F</sub> = 20 A, di/dt = 100 A/μs, T <sub>J</sub> = 25 °C		93	128	nC
Reverse Recovery Fall Time	t <sub>a</sub>	i <sub>F</sub> - 20 A, α//αι = 100 A/μs, 1 <sub>J</sub> = 25 °C		27		ns
Reverse Recovery Rise Time	t <sub>b</sub>			21		

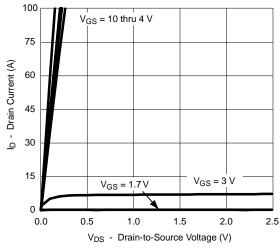
### Notes:

- a. Pulse test; pulse width  $\leq 300~\mu s,$  duty cycle  $\leq 2~\%.$
- b. Guaranteed by design, not subject to production testing.

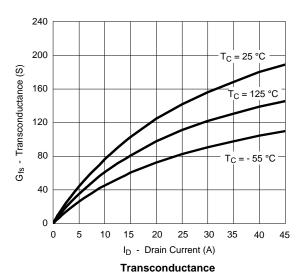
Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

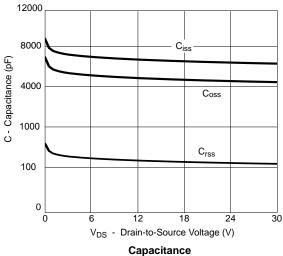


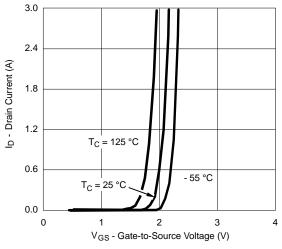
# TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)



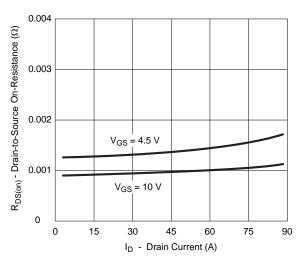
### **Output Characteristics**



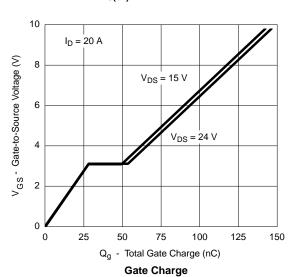




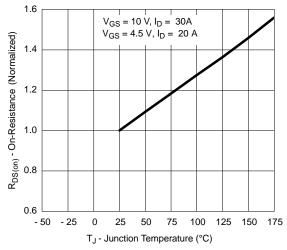
**Transfer Characteristics** 



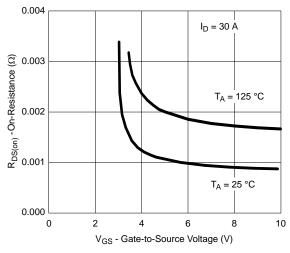
R<sub>DS(on)</sub> vs. Drain Current



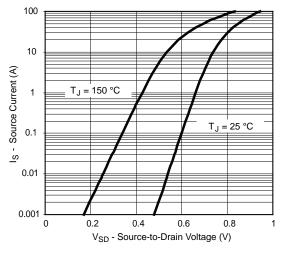
## TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)



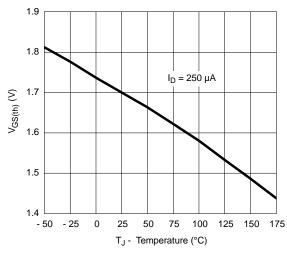
### On-Resistance vs. Junction Temperature



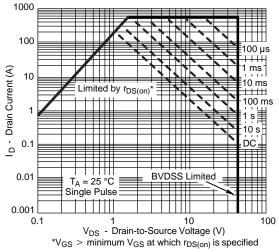
 $R_{DS(on)}$  vs.  $V_{GS}$  vs. Temperature



Forward Diode Voltage vs. Temperature

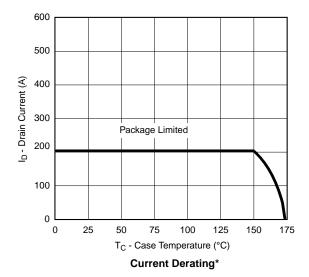


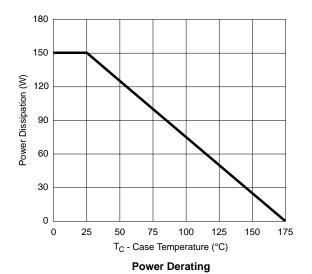
Threshold Voltage



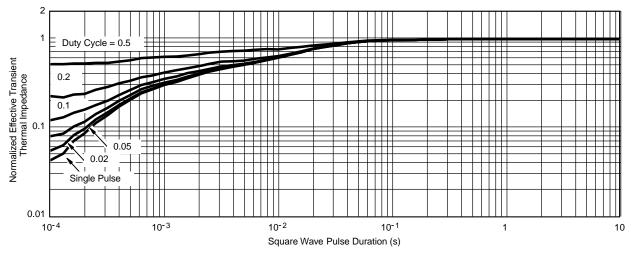
Safe Operating Area, Junction-to-Ambient

## TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)





<sup>\*</sup> The power dissipation  $P_D$  is based on  $T_{J(max)} = 175$  °C, using junction-to-case thermal resistance, and is more useful in settling the upper dissipation limit for cases where additional heatsinking is used. It is used to determine the current rating, when this rating falls below the package limit.



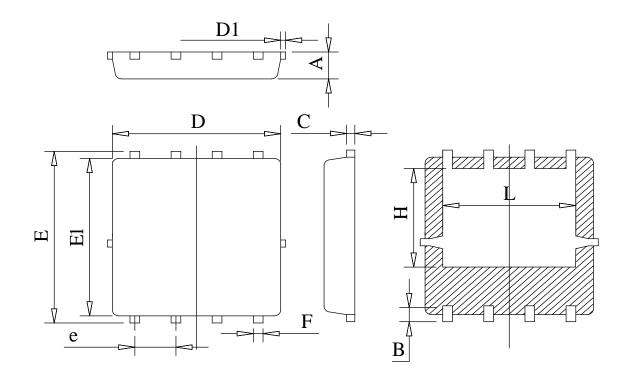
Normalized Thermal Transient Impedance, Junction-to-Case



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# DFN5X6-8L PACKAGE OUTLINE



# COMMON DIMENSIONS (UNITS OF MEASURE=MILLIMETER)

Unit: mm

Symbol	Min	Тур	Max
A	0.78	0.95	1.12
В	0.45	0.58	0.78
С	0.18	0.254	0.36
D	4.70	5.20	5.45
D1			0.18
Е	5.85	6.05	6.25
E1	5.38	5.55	5.98
e	1.15	1.27	1.40
F	0.18	0.30	0.52
Н	3.25	3.47	3.70
L	3.75	4.00	4.25





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